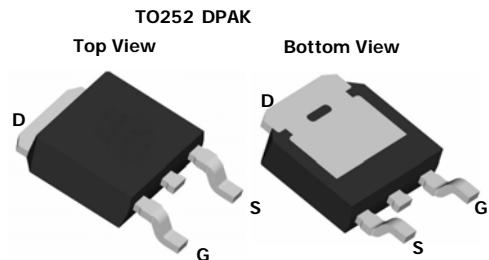


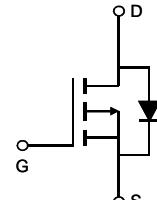
Features

- -100V, -15A
- $R_{DS(ON)} \text{ Typ} = 162 \text{ m}\Omega @ V_{GS} = -10\text{V}$
- $R_{DS(ON)} \text{ Typ} = 179 \text{ m}\Omega @ V_{GS} = -4.5\text{V}$
- Excellent $R_{DS(ON)}$ and Low Gate Charge



Application

- Load Switch
- PWM Application
- Power Management



Absolute Maximum Ratings ($T_A=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter		Max.	Units
V_{DSS}	Drain-Source Voltage		-100	V
V_{GSS}	Gate-Source Voltage		± 20	V
I_D	Continuous Drain Current	$T_A = 25^\circ\text{C}$	-15	A
		$T_A = 100^\circ\text{C}$	-7.5	
I_{DM}	Pulsed Drain Current ^{note1}		-75	A
P_D	Power Dissipation	$T_A = 25^\circ\text{C}$	104	W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient		1.2	$^\circ\text{C}/\text{W}$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristic						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}$, $I_D=-250\mu\text{A}$	-100	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-80\text{V}$, $V_{GS}=0\text{V}$,	-	-	-1	μA
I_{GSS}	Gate to Body Leakage Current	$V_{DS}=0\text{V}$, $V_{GS}=\pm 20\text{V}$	-	-	± 100	nA
On Characteristics						
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_D=-250\mu\text{A}$	-1.4	-1.9	-2.6	V
$R_{DS(\text{on})}$ note2	Static Drain-Source on-Resistance	$V_{GS}=-10\text{V}$, $I_D=-3\text{A}$		162	180	mΩ
		$V_{GS}=-4.5\text{V}$, $I_D=-3.0\text{A}$		179	200	
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=-25\text{V}$, $V_{GS}=0\text{V}$, $f=1.0\text{MHz}$		1230		pF
C_{oss}	Output Capacitance		-	622	-	pF
C_{rss}	Reverse Transfer Capacitance		-	44	-	pF
Q_g	Total Gate Charge	$V_{DS}=-50\text{V}$, $I_D=-3\text{A}$, $V_{GS}=-0-10\text{V}$	-	19	-	nC
Q_{gs}	Gate-Source Charge		-	7	-	nC
Q_{gd}	Gate-Drain("Miller") Charge		-	4	-	nC
Switching Characteristics						
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=-50\text{V}$, $I_D=-3\text{A}$, $R_G=6\Omega$, $V_{GEN}=-10\text{V}$	-	10	-	ns
t_r	Turn-on Rise Time		-	55	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	40	-	ns
t_f	Turn-off Fall Time		-	75	-	ns
Drain-Source Diode Characteristics and Maximum Ratings						
I_s	Maximum Continuous Drain to Source Diode Forward Current		-	-	-15	A
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-75	A
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS}=0\text{V}$, $I_s=-3\text{A}$	-	-	-0.7	V

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
2. E_{AS} condition: Starting $T_J=25^\circ\text{C}$, $V_{DD}=-50\text{V}$, $V_G=-10\text{V}$, $R_G=25\text{ohm}$, $L=0.5\text{mH}$, $I_{AS}=-21\text{A}$
3. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 0.5\%$.

Test Circuit

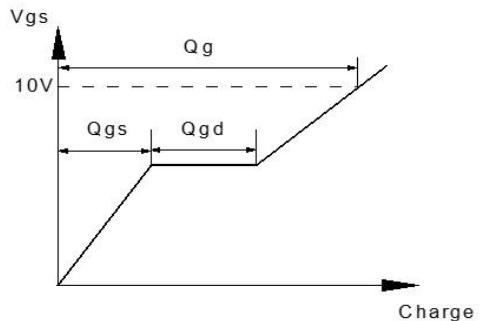
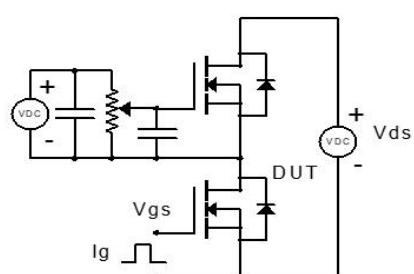


Figure 1: Gate Charge Test Circuit & Waveform

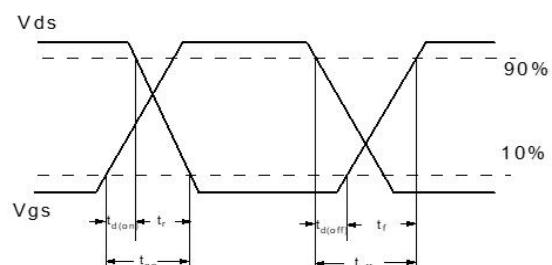
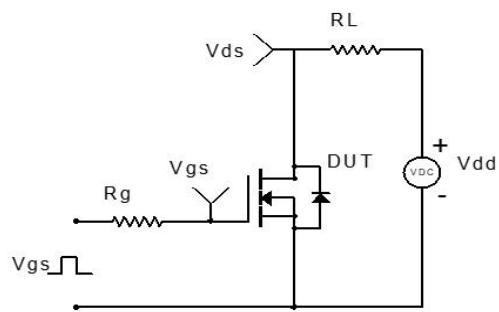


Figure 2: Resistive Switching Test Circuit & Waveform

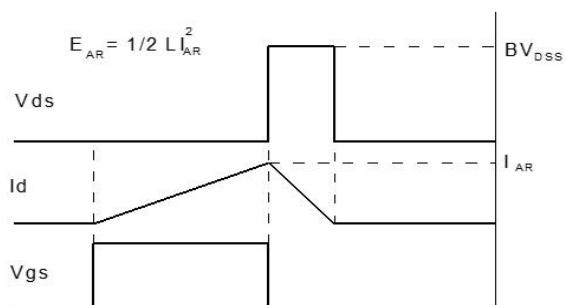
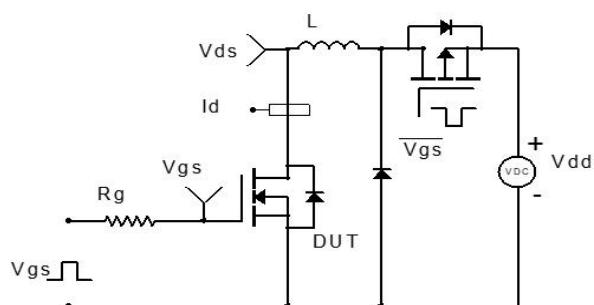


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

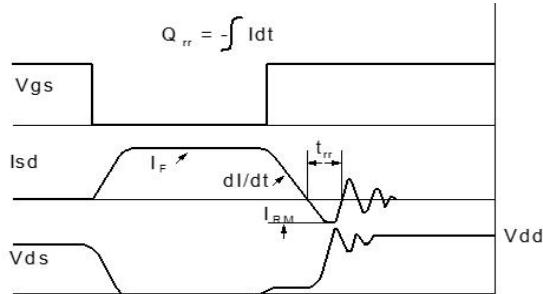
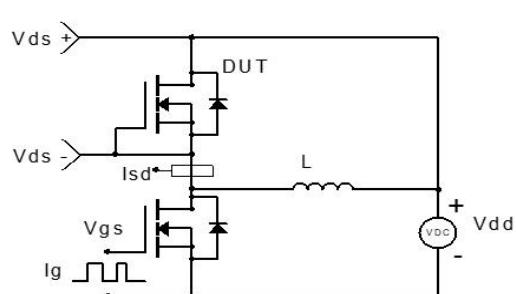
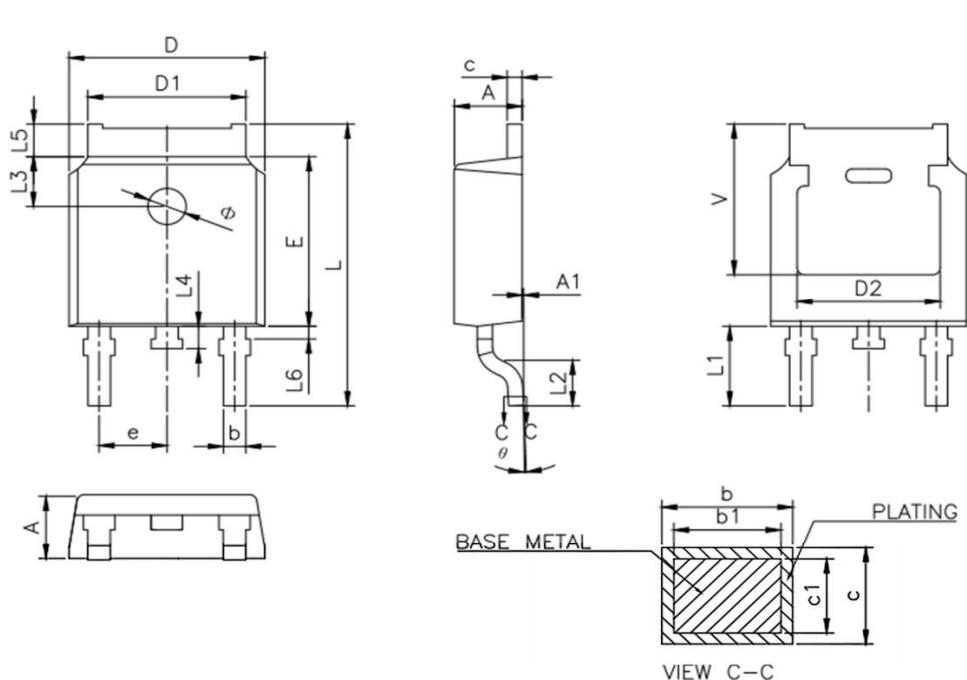


Figure 4: Diode Recovery Test Circuit & Waveform

Package Mechanical Data(TO-252-3L)



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	2.20	2.30	2.40
A1	0.00	--	0.127
b	0.66	--	0.86
b1	0.65	0.76	0.81
D	6.50	6.60	6.70
D1	5.10	5.33	5.46
c	0.47	--	0.60
c1	0.46	0.51	0.56
D2		4.83	REF.
E	6.00	6.10	6.20
e	2.186	2.286	2.386
L	9.80	10.10	10.40
L1		2.90	REF.
L2	1.40	1.50	1.60
L3		1.80	REF.
L4	0.60	0.80	1.00
L5	0.90	--	1.25
L6	0.15	--	0.75
Φ	1.10	--	1.30
θ	0°	--	8°
V		5.40	REF